勝 特 力 材 料 886-3-5753170 胜特力电子(上海) 86-21-34970699 胜特力电子(深圳) 86-755-83298787 Http://www.100v.com.tw

SN65HVD1050A-Q1

SLLS888A - JUNE 2008 - REVISED JANUARY 2011

EMC-OPTIMIZED HIGH SPEED CAN TRANSCEIVER

Check for Samples: SN65HVD1050A-Q1

FEATURES

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- Qualified for Automotive Applications
- Improved Drop-In Replacement for TJA1050
- Meets or Exceeds the Requirements of ISO 11898-2
- GIFT/ICT Compliant
- ESD Protection up to ±12 kV (Human-Body Model) on Bus Pins
- High Electromagnetic Compliance (EMC)
- Bus-Fault Protection of –27 V to 40 V
- Dominant Time-Out Function
- Thermal Shutdown Protection
- Power-Up/Down Glitch-Free Bus Inputs and Outputs
 - High Input Impedance With Low V_{CC}
 - Monotonic Outputs During Power Cycling

APPLICATIONS

- GMW3122 Dual-Wire CAN Physical Layer
- SAE J2284 High-Speed CAN for Automotive Applications
- SAE J1939 Standard Data Bus Interface
- ISO 11783 Standard Data Bus Interface
- NMEA 2000 Standard Data Bus Interface

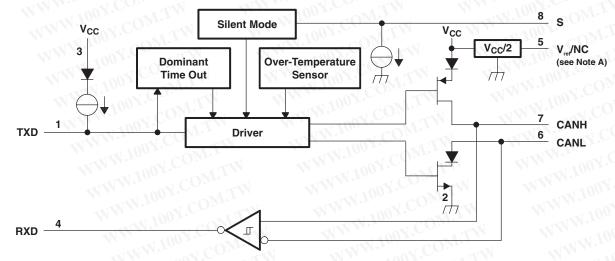
DESCRIPTION

The SN65HVD1050A meets or exceeds the specifications of the ISO 11898 standard for use in applications employing a Controller Area Network (CAN). The device is qualified for use in automotive applications.

As a CAN transceiver, this device provides differential transmit capability to the bus and differential receive capability to a CAN controller at signaling rates up to 1 megabit per second (Mbps)⁽¹⁾.

(1) The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

FUNCTION BLOCK DIAGRAM



V_{ref} on SN65HVD1050A, NC on SN65HVD1050AL



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

DESCRIPTION (CONTINUED)

Designed for operation is especially harsh environments, the SN65HVD1050A features cross-wire, over-voltage, and loss of ground protection from –27 V to 40 V, over-temperature protection, a –12-V to 12-V common-mode range, and withstands voltage transients according to ISO 7637.

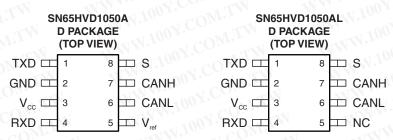
Pin 8 provides for two different modes of operation: high-speed or silent mode. The high-speed mode of operation is selected by connecting S (pin 8) to ground.

If a high logic level is applied to the S pin of the SN65HVD1050A, the device enters a listen-only silent mode during which the driver is switched off while the receiver remains fully functional.

In silent mode, all bus activity is passed by the receiver output to the local protocol controller. When data transmission is required the local protocol controller must transition the device to high speed mode by placing a logic low on the S pin to resume full operation.

A dominant time-out circuit in the SN65HVD1050A prevents the driver from blocking network communication with a hardware or software failure. The time-out circuit is triggered by a falling edge on TXD (pin 1). If no rising edge is seen before the time-out constant of the circuit expires, the driver is disabled. The circuit is then reset by the next rising edge on TXD.

 V_{ref} (pin 5) is available as a $V_{CC}/2$ voltage reference.



NC - No internal connection

ORDERING INFORMATION(1)

T _A	PAC	CKAGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
1000 1- 10500	0010	D1 - (0500	SN65HVD1050AQDRQ1	1050AQ
–40°C to 125°C	SOIC - D	Reel of 2500	SN65HVD1050ALQDRQ1	MM, 1100X-COM

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

⁽²⁾ Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



ABSOLUTE MAXIMUM RATINGS⁽¹⁾

		UNIT
V _{CC}	Supply voltage range ⁽²⁾	-0.3 V to 6 V
OM.	Voltage range at any bus terminal (CANH, CANL, V _{ref})	–27 V to 40 V
lo	Receiver output current	20 mA
V_{I}	Voltage input range, ISO 7637 transient pulse (3) (CANH, CANL)	–150 V to 100 V
V_{L}	Voltage input range (TXD, S)	-0.3 V to 6 V
TJ	Junction temperature range	-40°C to 150°C

- Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
- Tested in accordance with ISO 7637 test pulses 1, 2, 3a, 3b per IBEE system level test (Pulse 1 = -100 V, Pulse 2 = 100 V, Pulse 3a = -150 V, Pulse 3b = 100 V). If dc may be coupled with ac transients, externally protect the bus pins within the absolute maximum voltage range at any bus terminal. This device has been tested with dc bus shorts to +40V with leading common-mode chokes. If common-mode chokes are used in the system and the bus lines may be shorted to dc, ensure that the choke type and value in combination with the node termination and shorting voltage either will not create inductive flyback outside of voltage maximum specification or use an external transient-suppression circuit to protect the transceiver from the inductive transients.

ELECTROSTATIC DISCHARGE PROTECTION

PARAMETER	W.Ing	TEST CONDITIONS	UNIT
W 1007.	V VV 10	CANH and CANL bus pins (3)	±12 kV
	Human-Body Model (2)	V _{ref} pin ⁽⁴⁾	±10 kV
Electrostatic discharge (1)	TW WWW.	All pins	±4 kV
	Charged-Device Model (5)	All pins	±1.5 kV
	Machine Model (6)	Aina COM.	±200 V

- All typical values at 25°C. (1)
- Tested in accordance JEDEC Standard 22, Test Method A114E. (2)
- Test method based upon JEDEC Standard 22 Test Method A114E, CANH and CANL bus pins stressed with respect to each other and GND.
- Test method based upon JEDEC Standard 22 Test Method A114E, V_{ref} pin stressed with respect to GND.
- Tested in accordance JEDEC Standard 22, Test Method C101C. (5)
- Tested in accordance JEDEC Standard 22, Test Method A115A.

RECOMMENDED OPERATING CONDITIONS

	MANA COM.	IN. TOW. COME THE WAY	MIN	MAX	UNIT
V _{CC}	Supply voltage	MAN TOO ST COM.	4.75	5.25	V
V _I or V _{IC}	Voltage at any bus terminal (separately or common i	mode)	-12	12	V
V _{IH}	High-level input voltage	TXD, S	20	5.25	V
V_{IL}	Low-level input voltage	TXD, S	0	8.0	V
V_{ID}	Differential input voltage	MAN. TO COM. THE	-6	6	V
	High level auto Million	Driver	-70	Jac	
I _{OH}	High-level output current	Receiver	-2	1.100	mA
	MANN OUX COS TW	Driver	4/1/1/	70	,
I _{OL}	Low-level output current	Receiver	WW	2	mA
T _A	Operating free-air temperature range	See Thermal Characteristics table	-40	125	°C

SUPPLY CURRENT

over recommended operating conditions. $T_{\Delta} = -40$ to 125°C (unless otherwise noted)

	PARAMETE	ER CONTRACTOR	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
	AA .	Silent mode	S at V_{CC} , $V_I = V_{CC}$	$0_{M^{*}}$	6	10	
I _{CC} 5-V supply current	Dominant	$V_I = 0 \text{ V}, 60-\Omega \text{ load}, \text{ S at } 0 \text{ V}$	OWIL	50	70	mA	
		Recessive	V _I = V _{CC} , No load, S at 0 V		6	10	

⁽¹⁾ All typical values are at 25°C with a 5-V supply.

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DEVICE SWITCHING CHARACTERISTICS

over recommended operating conditions, $T_{\Delta} = -40$ to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
t _{d(LOOP1)}	Total loop delay, driver input to receiver output, recessive to dominant	S at 0 V, See Figure 9	90	230	ns
t _{d(LOOP2)}	Total loop delay, driver input to receiver output, dominant to recessive	S at 0 V, See Figure 9	90	230	ns

MW.100Y DRIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions, $T_A = -40$ to 125°C (unless otherwise noted)

COP.	PARAMETER	any.Cu	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNI
V -1 CO	Bus output voltage (dominant)	CANH	$V_I = 0 \text{ V}$, S at 0 V, $R_L = 60 \Omega$, See Figure 1	2.9	3.4	4.5	V
$V_{O(D)}$	Bus output voltage (dominant)	CANL	and Figure 2	0.8		1.5	V
V _{O(R)}	Bus output voltage (recessive)	1.100X	V_I = 3 V, S at 0 V, R_L = 60 Ω , See Figure 1 and Figure 2	2	2.3	3	V
W.100 7.	CONT.	W.100	$V_I = 0 \text{ V}, R_L = 60 \Omega, S \text{ at } 0 \text{ V}, \text{ See Figure 1},$ Figure 2, and Figure 3	1.5	TW	3	V
$V_{OD(D)}$	Differential output voltage (dom	inant)	$V_I = 0 \text{ V}, R_L = 45 \Omega, S \text{ at } 0 \text{ V}, \text{ See Figure 1},$ Figure 2, and Figure 3	1.4	LTW.	3	V
W W.	Differential output valtege (rese	agira) 1	V _I = 3 V, S at 0 V, See Figure 1 and Figure 2	-0.012	N.T.W	0.012	V
$V_{OD(R)}$	Differential output voltage (rece	ssive)	V _I = 3 V, S at 0 V, No Load	-0.5	VITI	0.05	V
V _{OC(ss)}	Steady state common-mode ou voltage	tput	S at 0 V, Figure 8	2	2.3	3	V
$\Delta V_{OC(ss)}$	Change in steady-state common-mode output voltage		S at 0 V, rigule 0	100 X.C	30	LM	m۷
I _{IH}	High-level input current, TXD in	put	V _I at V _{CC}	_2	COM	2	
I _{IL}	Low-level input current, TXD inp	out	V _I at 0 V	-50		-10	μΑ
I _{O(off)}	Power-off TXD output current	V.	V _{CC} at 0 V, TXD at 5 V	100	M.Co.	1	V
			V _{CANH} = -12 V, CANL open, See Figure 11	-105	-72)Mr.	W
	Short aircuit atoody atota autou	t ourront	V _{CANH} = 12 V, CANL open, See Figure 11	W.1V	0.36	0 1	mΑ
I _{OS(ss)}	Short-circuit steady-state output	t current	V _{CANL} = -12 V, CANH open, See Figure 11	-1	-0.5	Mon	IIIA
4	NAM. TON COMP	V	V _{CANL} = 12 V, CANH open, See Figure 11	MM	71	105	TW
Co	Output capacitance		See receiver input capacitance	WWW		$^{(CO)_{h}}$	

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WWW.100X.

⁽¹⁾ All typical values are at 25°C with a 5-V supply. WWW.100Y.COM.T



DRIVER SWITCHING CHARACTERISTICS

oover recommended operating conditions, $T_A = -40$ to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high level output	S at 0 V, See Figure 4	25	65	120	ns
t _{PHL}	Propagation delay time, high-to-low level output	S at 0 V, See Figure 4	25	45	120	ns
t _r	Differential output signal rise time	S at 0 V, See Figure 4		25		ns
tf	Differential output signal fall time	S at 0 V, See Figure 4		50		ns
t _{en}	Enable time from silent mode to dominant	See Figure 7	N		1	μS
t _(dom)	Dominant time out ⁽²⁾	↓V _I , See Figure 10	300	450	700	μS

All typical values are at 25°C with a 5-V supply.

RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions, $T_{\Delta} = -40$ to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	S at 0 V, See Table 3	The OA'	800	900	mV
V _{IT}	Negative-going input threshold voltage	S at 0 V, See Table 3	500	650	~ * T	mV
V _{hys}	Hysteresis voltage (V _{IT+} – V _{IT-})	100Y. CALITY	100	125		mV
V _{OH}	High-level output voltage	I _O = -2 mA, See Figure 6	4	4.6	TW	V
V_{OL}	Low-level output voltage	I _O = 2 mA, See Figure 6	MM	0.2	0.4	V
I _{I(off)}	Power-off bus input current	CANH or CANL = 5 V, Other pin at 0 V, V _{CC} at 0 V, TXD at 0 V	MM.I	165	250	μА
I _{O(off)}	Power-off RXD leakage current	V _{CC} at 0 V, RXD at 5 V	Wir	100 -	20	μΑ
Cı	Input capacitance to ground (CANH or CANL)	TXD at 3 V, V _I = 0.4 sin (4E6πt) + 2.5 V	WWW	13	OM.T	pF
C _{ID}	Differential input capacitance	TXD at 3 V, $V_I = 0.4 \sin (4E6\pi t)$	- TXX	6	COM	pF
R _{ID}	Differential input resistance	TXD at 3 V, S at 0 V	30	TN 100 Y	80	kΩ
R _{IN}	Input resistance (CANH or CANL)	TXD at 3 V, S at 0 V	15	30	40	kΩ
R _{I(m)}	Input resistance matching [1 – (R _{IN (CANL)})] × 100%	$V_{(CANH)} = V_{(CANL)}$	-3	0.0	3	%

⁽¹⁾ All typical values are at 25°C with a 5-V supply.

RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions, $T_A = -40$ to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high-level output	100Y.CO 11TY	60	100	130	ns
t _{PHL}	Propagation delay time, high-to-low-level output	S at 0 V or V _{CC} , See	45	70	130	ns
t _r	Output signal rise time	Figure 6	-XXI	8	M.I.	ns
t _f	Output signal fall time	100Y. COM.	1.4.	8	·WI	ns

(1) All typical values are at 25°C with a 5-V supply. WWW.100Y.COM.TW

The TXD dominant time out (t(dom)) will disable the driver of the transceiver once the TXD has been dominant longer than $t_{(dom)}$ which will release the bus lines to recessive preventing a local failure from locking the bus dominant. The driver may only transmit dominant again after TXD has been returned HIGH (recessive). While this protects the bus from local faults locking the bus dominant it will limit the minimum data rate possible. The CAN protocol allows a maximum of eleven successive dominant bits (on TXD) for the worst case where five successive dominant bits are followed immediately by an error frame. This along with the $t_{(dom)}$ minimum will limit the minimum bit rate. The minimum bit rate may be calculated by: Minimum Bit Rate = 11/ $t_{(dom)}$ = 11 bits / 300μ s = 37 kbps.



S PIN CHARACTERISTICS

over recommended operating conditions, $T_{\Delta} = -40$ to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
I _{IH}	High level input current	S at 2 V	20	40	70	μΑ
I _{IL}	Low level input current	S at 0.8 V	5	20	30	μΑ

⁽¹⁾ All typical values are at 25°C with a 5-V supply.

V_{ref} PIN CHARACTERISTICS⁽¹⁾

V _{ref} F	PIN CHARACTERISTICS	1007.007.0				
over r	ecommended operating conditi	ions, $T_A = -40$ to 125°C (unless otherwise noted)				
01.	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Vo	Reference output voltage	–50 μA < I _O < 50 μA	0.4 V _{CC}	0.5 V _{CC}	0.6 V _{CC}	V

⁽¹⁾ Available only on SN65HVD1050A, not on SN65HVD1050AL.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
NN		Low-K thermal resistance ⁽²⁾	CO	211		0000
θ_{JA}	Junction-to-air thermal resistance ⁽¹⁾	High-K thermal resistance ⁽²⁾	A'COM?	131		°C/W
ЭЈВ	Junction-to-board thermal resistance	MA:100 CON:14	=1 CON	53	*I	°C/W
$\theta_{\sf JC}$	Junction-to-case thermal resistance	1 100X. ON:IN W. 11110	01.	79	N.	°C/W
W	NW.100X.COM.TW	V_{CC} = 5 V, T_J = 27°C, R_L = 60 Ω , S at 0 V, Input to TXD at 500 kHz, 50% duty cycle square wave, CL at RXD = 15 pF	100X.C	112	TW	\^/
P _D	Average power dissipation	V_{CC} = 5.5 V, T_J = 130°C, R_L = 45 Ω , S at 0 V, Input to TXD at 500 kHz, 50% duty cycle square wave, CL at RXD = 15 pF	100X	COV	170	mW
	Thermal shutdown temperature	COM. TO COM.	M.In.	190	Mr.	√°C

The junction temperature (T_J) is calculated using the following T_J = T_A + (P_D * θ _{JA}).

All typical values are at 25°C with a 5-V supply.

Tested in accordance with the Low-K (EIA/JESD51-3) or High-K (EIA/JESD51-7) thermal metric definitions for leaded surface-mount WWW.100Y.COM.TW packages.



WWW.100Y.COA

FUNCTION TABLES

Table 1. DRIVER (1)

	COM. T	able 1. DRIVER	(1)	
INP	UTS	OUTF	PUTS	TW DUC STATE
TXD	SMA	CANH	CANL	BUS STATE
L	L or Open	Н	N.1005. COL	Dominant
H	X	Z	Z	Recessive
Open	X	W Z W	Z	Recessive
X	M. Jon H COM	Z	Z	Recessive

Table 2. RECEIVER⁽¹⁾

DIFFERENTIAL INPUTS V _{ID} = V(CANH) - V(CANL)	OUTPUT RXD	BUS STA
V _{ID} ≥ 0.9 V	COM-F	Dominant
0.5 V < V _{ID} < 0.9 V	?	1003
V _{ID} ≤ 0.5 V	HTW	Recessive
Open	COH	Recessive

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100Y.COM.TW



PARAMETER MEASUREMENT INFORMATION

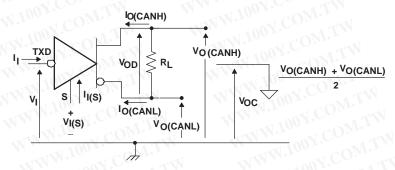


Figure 1. Driver Voltage, Current, and Test Definition

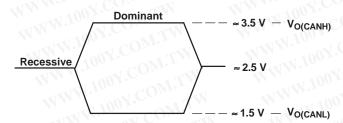


Figure 2. Bus Logic State Voltage Definitions

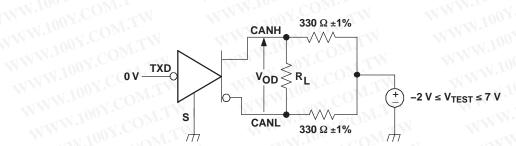


Figure 3. Driver VoD Test Circuit

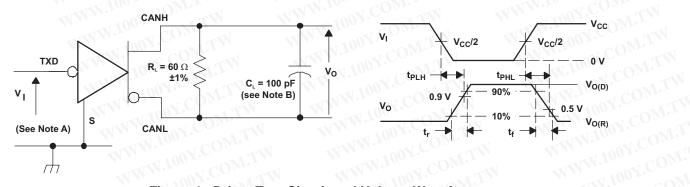


Figure 4. Driver Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION (continued)

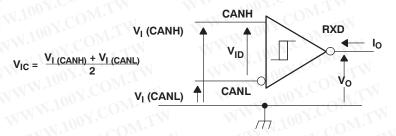
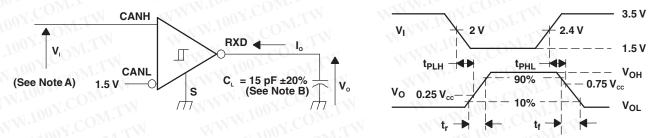


Figure 5. Receiver Voltage and Current Definitions



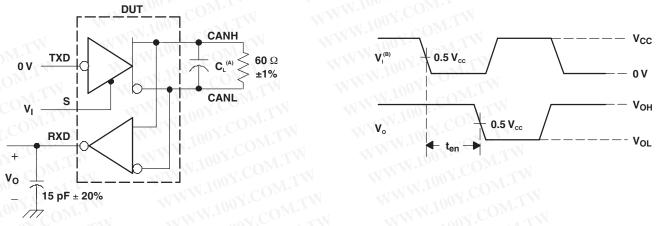
- The input pulse is supplied by a generator having the following characteristics: PRR ≤ 125 kHz, 50% duty cycle, $t_r \le 6 \text{ ns}, t_f \le 6 \text{ ns}, Z_O = 50 \Omega.$
- C_L includes instrumentation and fixture capacitance within ±20%.

Figure 6. Receiver Test Circuit and Voltage Waveforms

Table 3. Differential Input Voltage Threshold Test

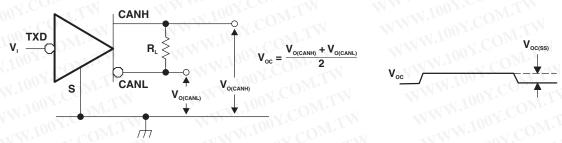
V _{CANH}	V _{CANL}	$ V_{ID} $	V	R
–11.1 V	–12 V	900 mV	L	MWW.IO
12 V	11.1 V	900 mV	L	N . 100 r
-6 V	-12 V	6 V	L	V _{OL}
12 V	6 V	6 V	N L	WW 1007
11.5 V	-12 V	500 mV	Н	WWW.
12 V	11.5 V	500 mV	Н	TWW.10
–12 V	−6 V	6 V	Н	V _{OH}
6 V	12 V	6 V	H	WW
Open	Open	XXXXCO	H	MM.





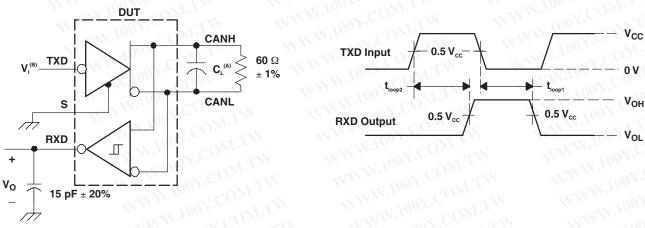
- A. $C_L = 100 \text{ pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.
- B. All V_1 input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 6$ ns, pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

Figure 7. ten Test Circuit and Waveforms



NOTE: All V_l input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r or $t_f \le 6$ ns, pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

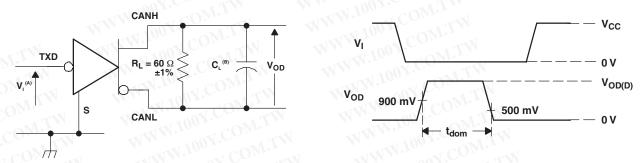
Figure 8. Common-Mode Output Voltage Test and Waveforms



- A. $C_L = 100 \text{ pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.
- B. All V₁ input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t₁ or t₁ ≤ 6 ns, pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

Figure 9. t_(LOOP) Test Circuit and Waveforms





- A. All V_1 input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r or $t_f \le 6$ ns, pulse repetition rate (PRR) = 500 Hz, 50% duty cycle.
- B. $C_1 = 100 \text{ pF}$ includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 10. Dominant Time-Out Test Circuit and Waveforms

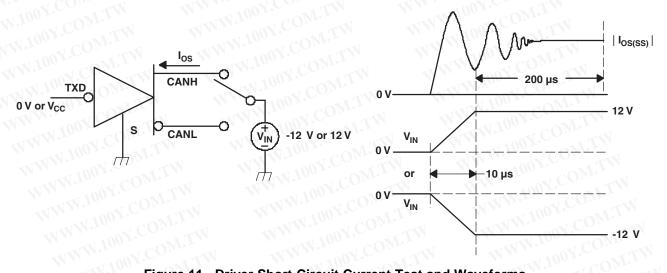


Figure 11. Driver Short-Circuit Current Test and Waveforms

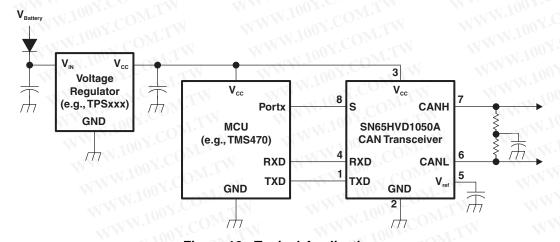
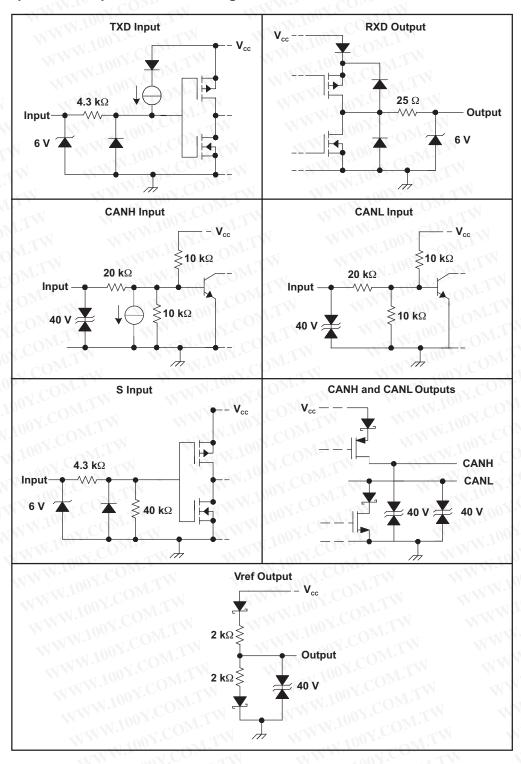


Figure 12. Typical Application



Equivalent Input and Output Schematic Diagrams





PACKAGE OPTION ADDENDUM

15-Jun-2009 www.ti.com

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN65HVD1050AQDRQ1	ACTIVE	SOIC	M D	8 2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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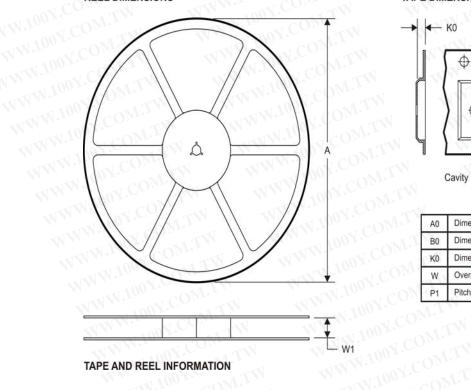
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PACKAGE MATERIALS INFORMATION

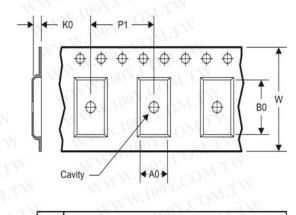
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TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



30 1	Dimension designed to accommodate the component length
K0 I	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

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TAPE AND REEL INFORMATION

*All dimensions are nominal

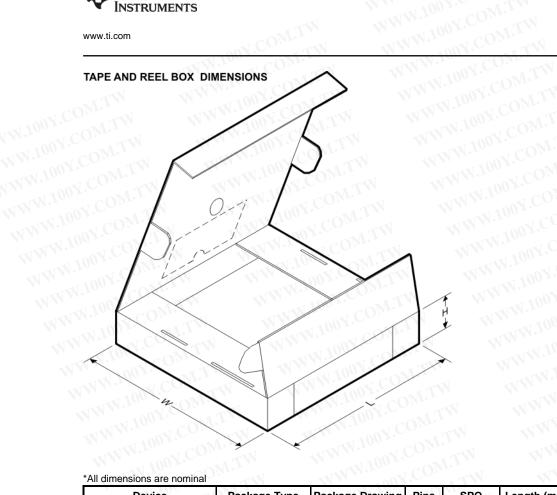
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65HVD1050AQDRQ1	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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*All dimensions are nominal

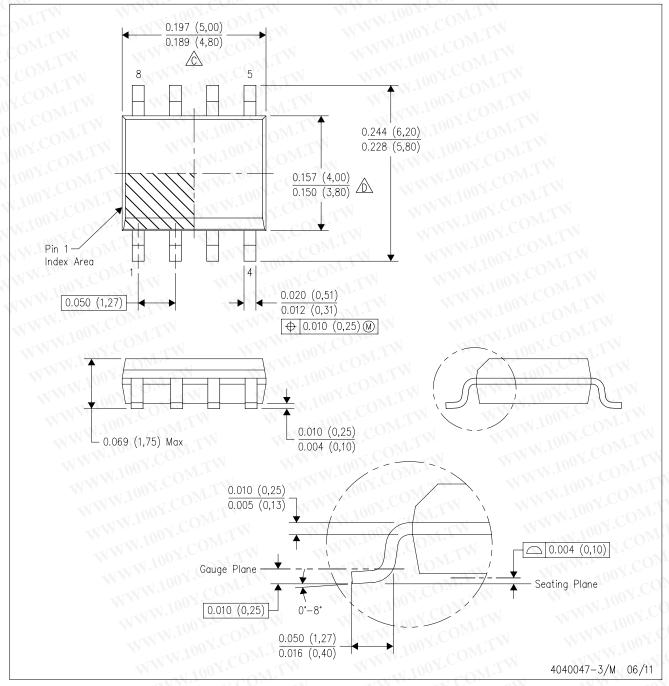
All dimensions are nominal	WITT -	1/1/1/1/1/02	0		T. William	1007.	MTV.
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65HVD1050AQDRQ1	SOIC	D	8	2500	367.0	367.0	35.0

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D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.

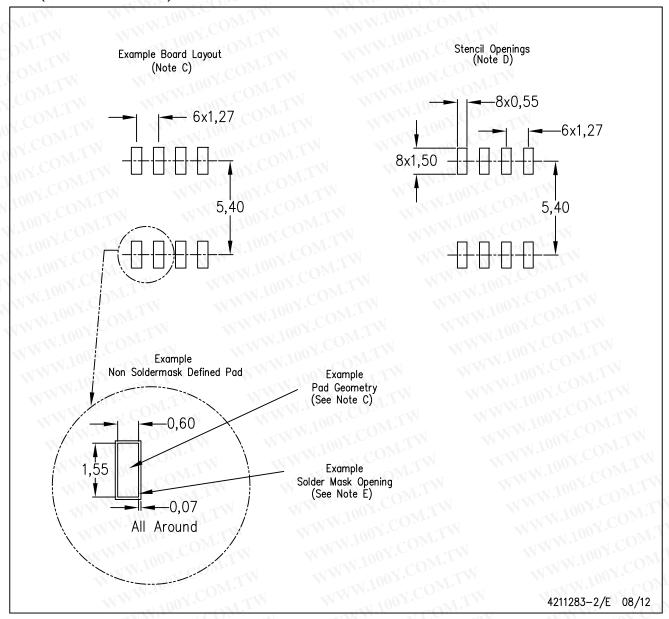
 Body width does not include interlead flash. Interlead flash shall

 E. Reference IEDEC No. 672
- E. Reference JEDEC MS-012 variation AA.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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